
APPENDIX C: RELEVANT PAGES FROM PROBE CALIBRATION REPORT(S)

E-field probe ER3DV6, SN: 2333
H-field probe H3DV6, SN: 6053



Accredited by the Swiss Federal Office of Metrology and Accreditation
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Cilent **Nokia Salo TCC**

Certificate No: **ER3-2333_Feb07**

CALIBRATION CERTIFICATE

Object **ER3DV6 - SN:2333**

Calibration procedure(s) **QA CAL-02.v4
Calibration procedure for E-field probes optimized for close near field
evaluations in air**

Calibration date: **February 13, 2007**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	5-Apr-06 (METAS, No. 251-00557)	Apr-07
Power sensor E4412A	MY41495277	5-Apr-06 (METAS, No. 251-00557)	Apr-07
Power sensor E4412A	MY41498087	5-Apr-06 (METAS, No. 251-00557)	Apr-07
Reference 3 dB Attenuator	SN: S5054 (3c)	10-Aug-06 (METAS, No. 217-00592)	Aug-07
Reference 20 dB Attenuator	SN: S5086 (20b)	4-Apr-06 (METAS, No. 251-00558)	Apr-07
Reference 30 dB Attenuator	SN: S5129 (30b)	10-Aug-06 (METAS, No. 217-00593)	Aug-07
Reference Probe ER3DV6	SN: 2328	2-Oct-06 (SPEAG, No. ER3-2328_Oct06)	Oct-07
DAE4	SN: 654	21-Jun-06 (SPEAG, No. DAE4-654_Jun06)	Jun-07
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (SPEAG, in house check Nov-05)	In house check: Nov-07
Network Analyzer HP 8753E	US37390585	18-Oct-01 (SPEAG, in house check Oct-06)	In house check: Oct-07

	Name	Function	Signature
Calibrated by:	Katja Pokovic	Technical Manager	
Approved by:	Niels Kuster	Quality Manager	

Issued: February 13, 2007

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DASY - Parameters of Probe: ER3DV6 SN:2333

Sensitivity in Free Space [$\mu\text{V}/(\text{V}/\text{m})^2$]		Diode Compression ^A	
NormX	1.44 ± 10.1 % (k=2)	DCP X	94 mV
NormY	1.50 ± 10.1 % (k=2)	DCP Y	94 mV
NormZ	1.46 ± 10.1 % (k=2)	DCP Z	99 mV

Frequency Correction

X	0.0
Y	0.0
Z	0.0

Sensor Offset (Probe Tip to Sensor Center)

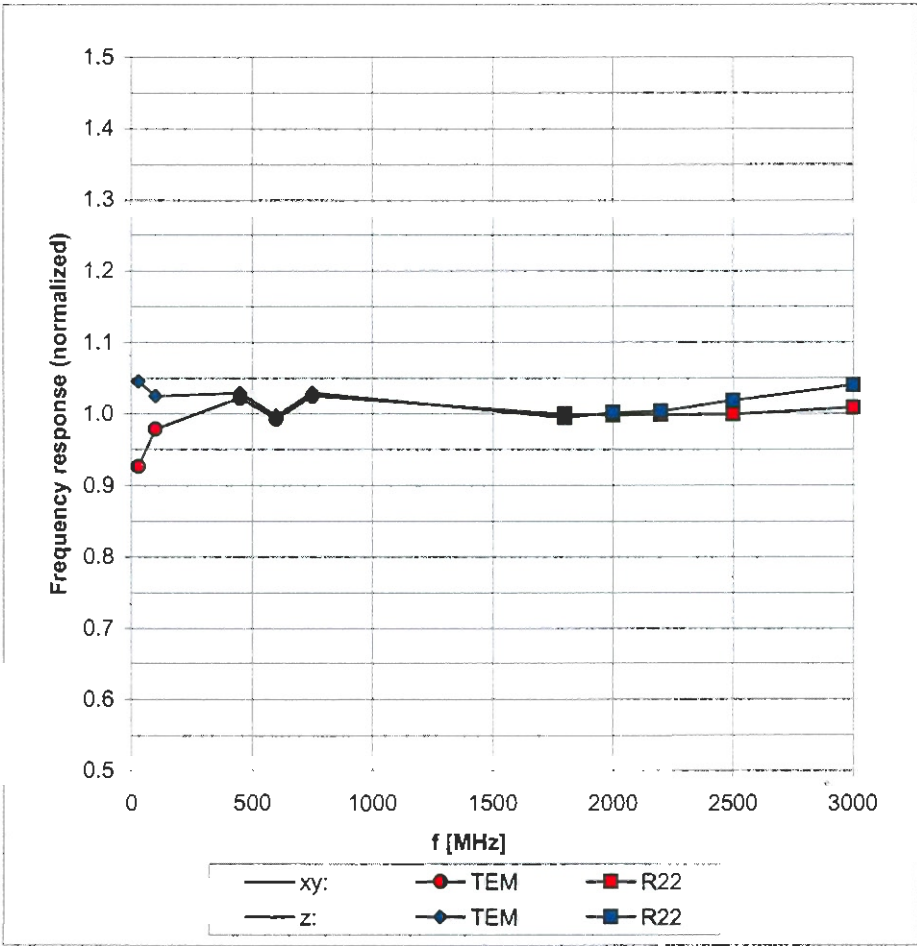
X	2.5 mm
Y	2.5 mm
Z	2.5 mm

Connector Angle -74 °

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

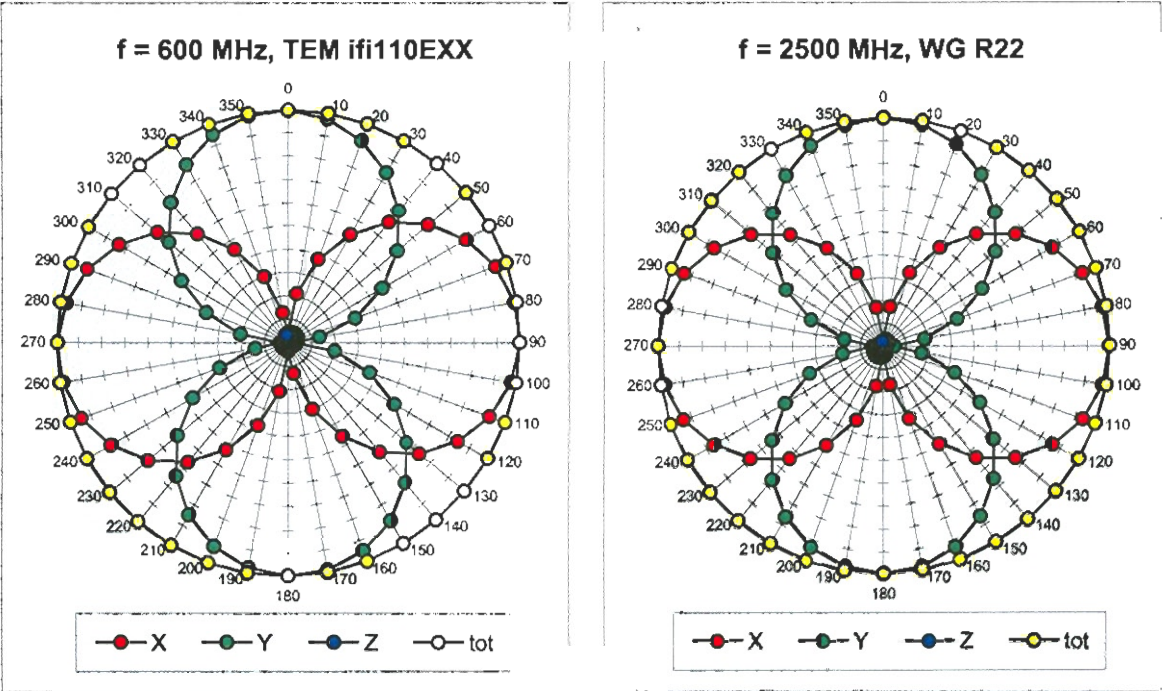
^A numerical linearization parameter: uncertainty not required

Frequency Response of E-Field
(TEM-Cell:ifi110 EXX, Waveguide R22)

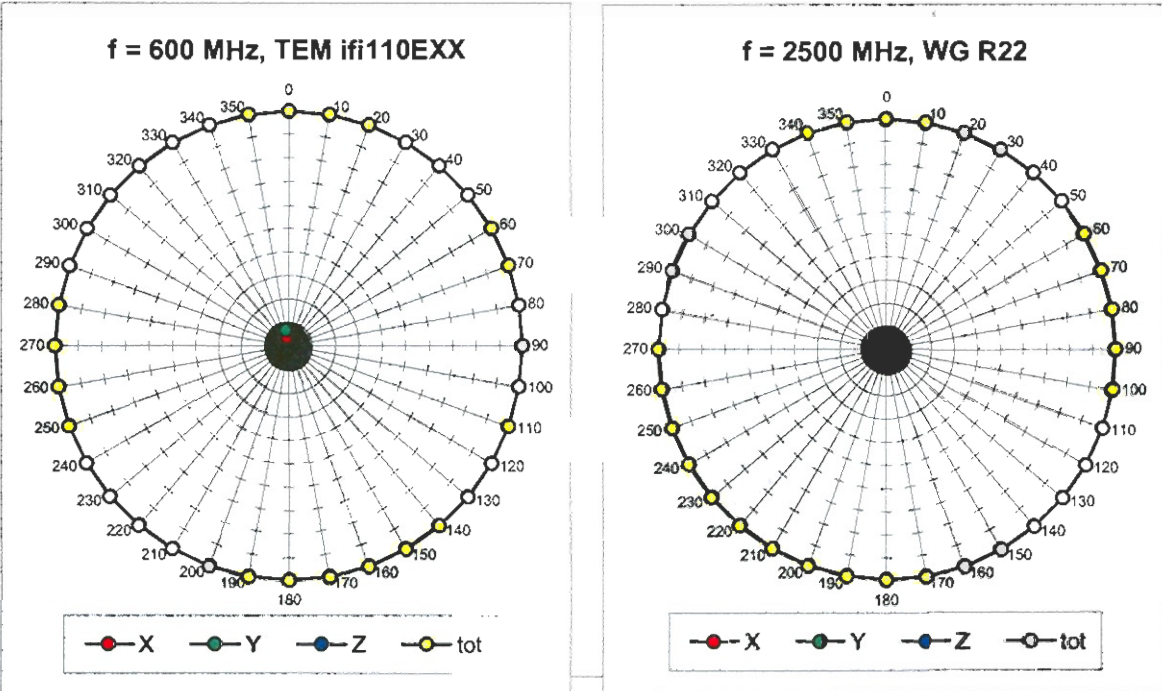


Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ (k=2)

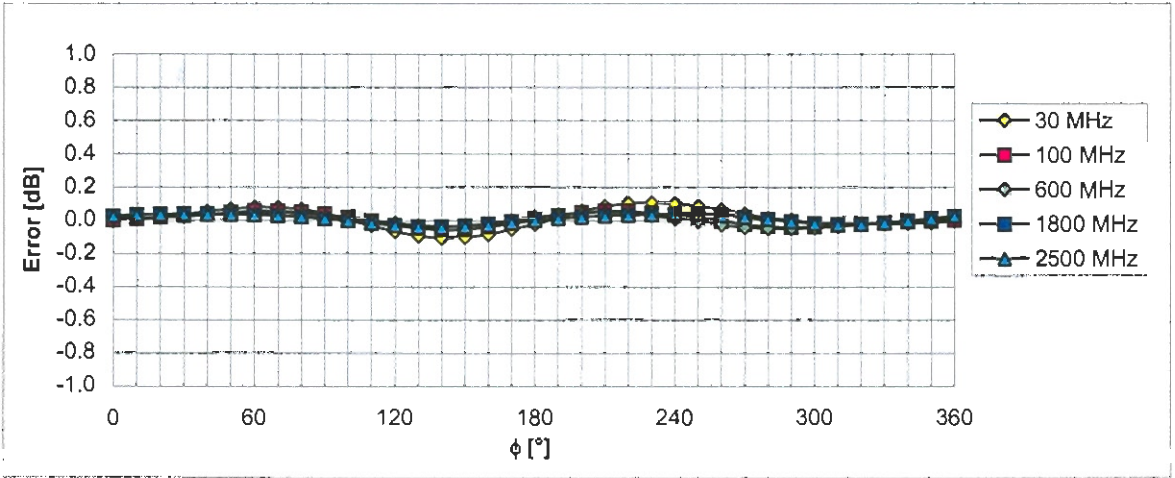
Receiving Pattern (ϕ), $\vartheta = 0^\circ$



Receiving Pattern (ϕ), $\vartheta = 90^\circ$

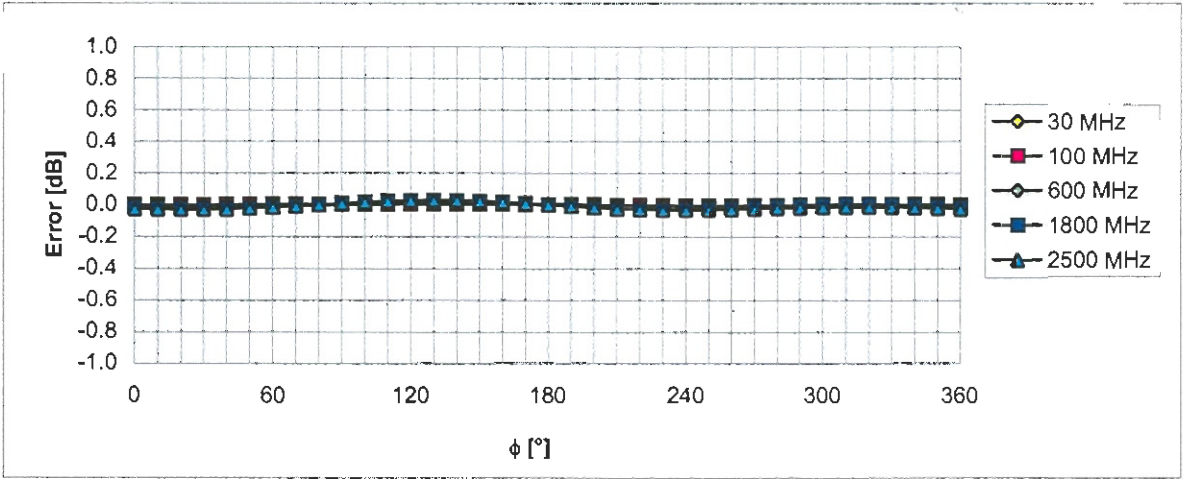


Receiving Pattern (ϕ), $\vartheta = 0^\circ$



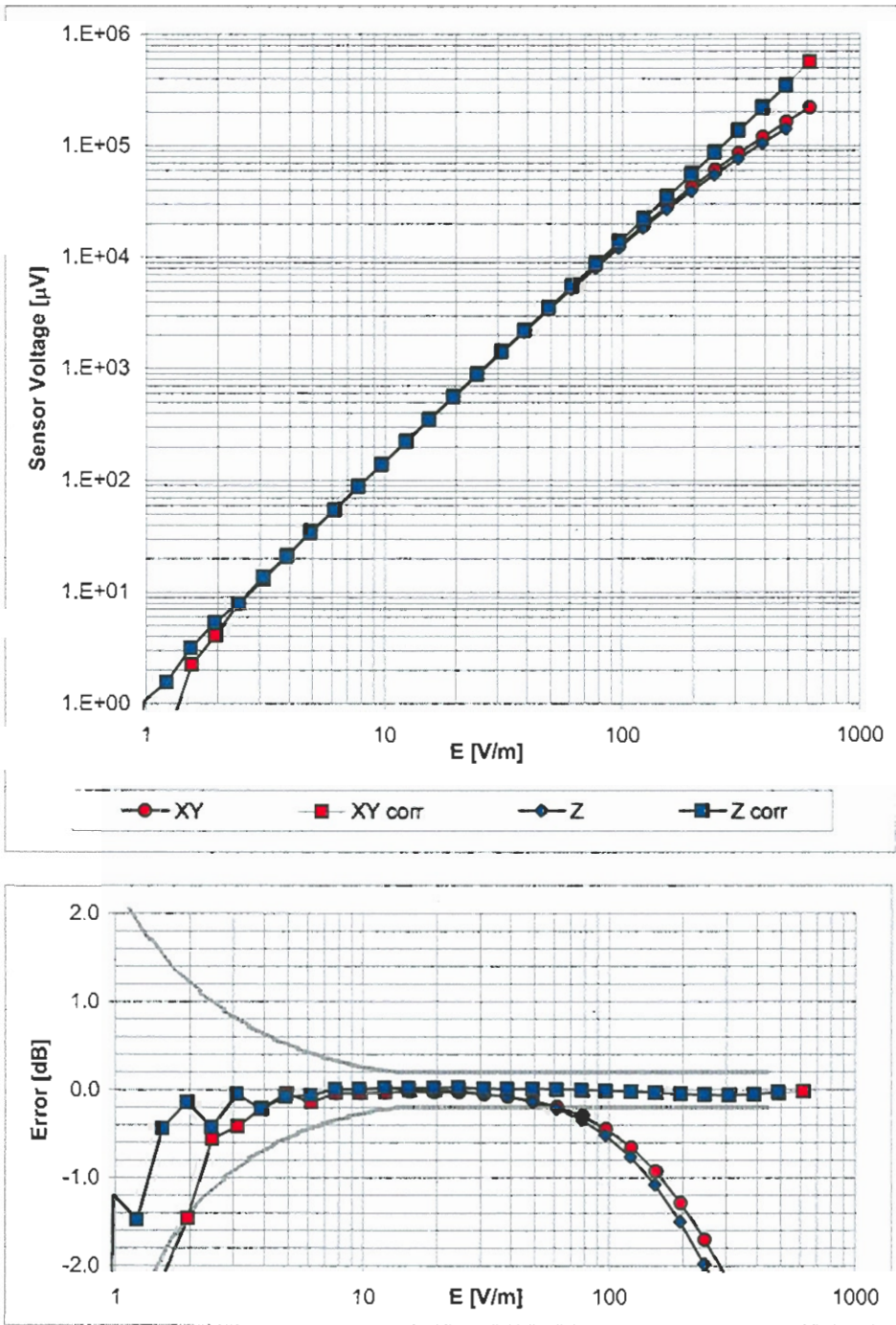
Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

Receiving Pattern (ϕ), $\vartheta = 90^\circ$



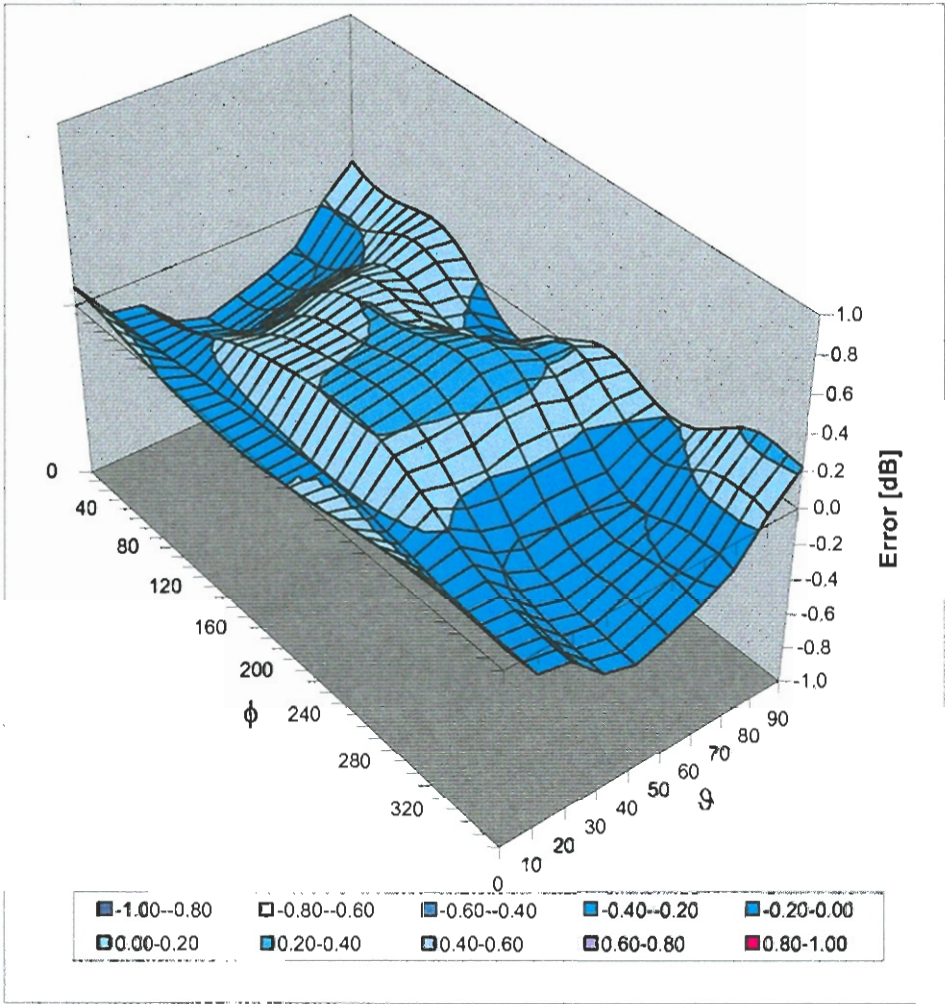
Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

Dynamic Range f(E-field)
(Waveguide R22, f = 1800 MHz)



Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Deviation from Isotropy in Air
Error (ϕ, ϑ) , $f = 900\text{ MHz}$



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)



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Accreditation No.: SCS 108

Client **Nokia Salo TCC**

Certificate No: **H3-6053_Feb07**

CALIBRATION CERTIFICATE

Object **H3DV6 - SN:6053**

Calibration procedure(s) **QA CAL-03.v4
Calibration procedure for H-field probes optimized for close near field
evaluations in air**

Calibration date: **February 13, 2007**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

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Power sensor E4412A	MY41498087	5-Apr-06 (METAS, No. 251-00557)	Apr-07
Reference 3 dB Attenuator	SN: S5054 (3c)	10-Aug-06 (METAS, No. 217-00592)	Aug-07
Reference 20 dB Attenuator	SN: S5086 (20b)	4-Apr-06 (METAS, No. 251-00558)	Apr-07
Reference 30 dB Attenuator	SN: S5129 (30b)	10-Aug-06 (METAS, No. 217-00593)	Aug-07
Reference Probe H3DV6	SN: 6182	2-Oct-06 (SPEAG, No. H3-6182_Oct06)	Oct-07
DAE4	SN: 654	21-Jun-06 (SPEAG, No. DAE4-654_Jun06)	Jun-07

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (SPEAG, in house check Nov-05)	In house check: Nov-07
Network Analyzer HP 8753E	US37390585	18-Oct-01 (SPEAG, in house check Oct-06)	In house check: Oct-07

	Name	Function	Signature
Calibrated by:	Katja Pokovic	Technical Manager	
Approved by:	Niels Kuster	Quality Manager	

Issued: February 13, 2007

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DASY - Parameters of Probe: H3DV6 SN:6053

Sensitivity in Free Space [A/m / $\sqrt{\mu V}$]

	a0	a1	a2
X	2.724E-03	-8.535E-5	-3.619E-5 ± 5.1 % (k=2)
Y	2.567E-03	-2.007E-4	7.239E-5 ± 5.1 % (k=2)
Z	2.914E-03	-3.715E-4	5.754E-5 ± 5.1 % (k=2)

Diode Compression¹

DCP X	85 mV
DCP Y	85 mV
DCP Z	85 mV

Sensor Offset (Probe Tip to Sensor Center)

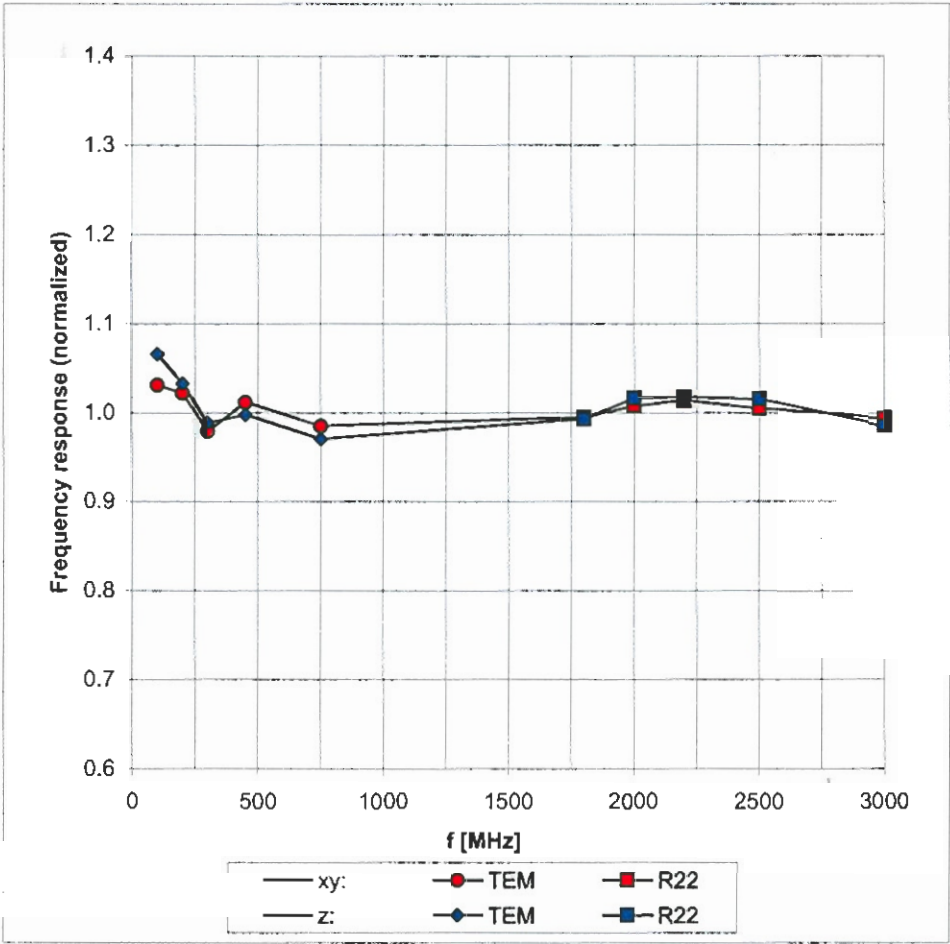
X	3.0 mm
Y	3.0 mm
Z	3.0 mm

Connector Angle 37 °

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

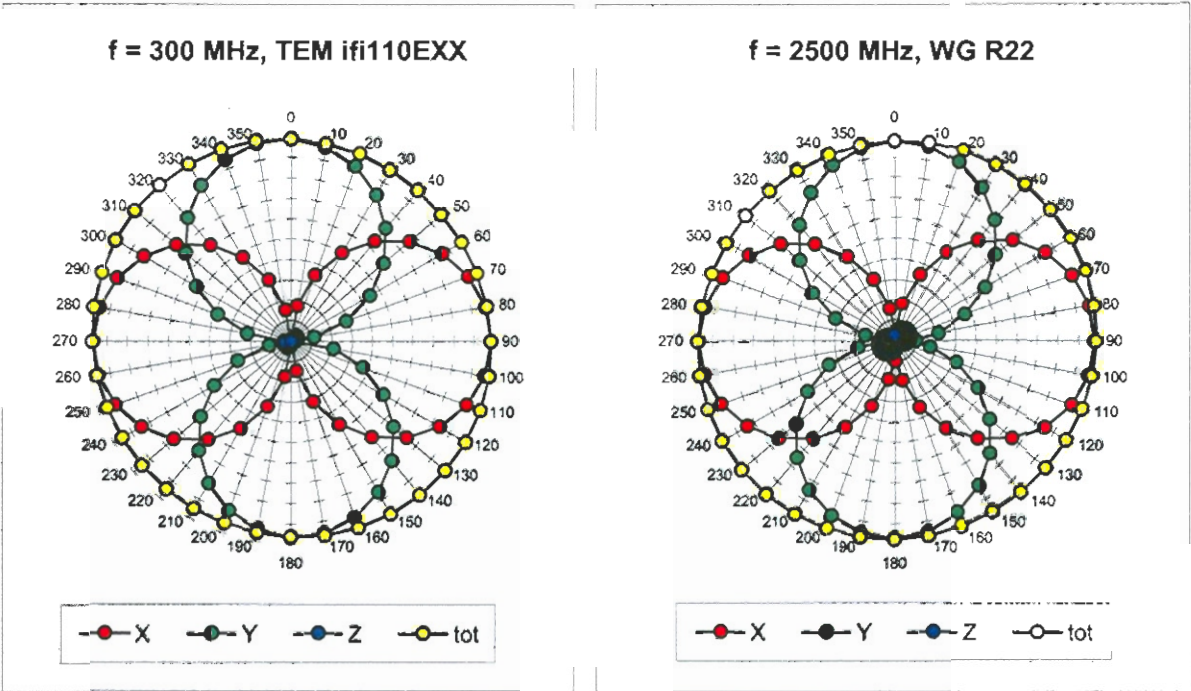
¹ numerical linearization parameter: uncertainty not required

Frequency Response of H-Field
(TEM-Cell:ifi110, Waveguide R22)

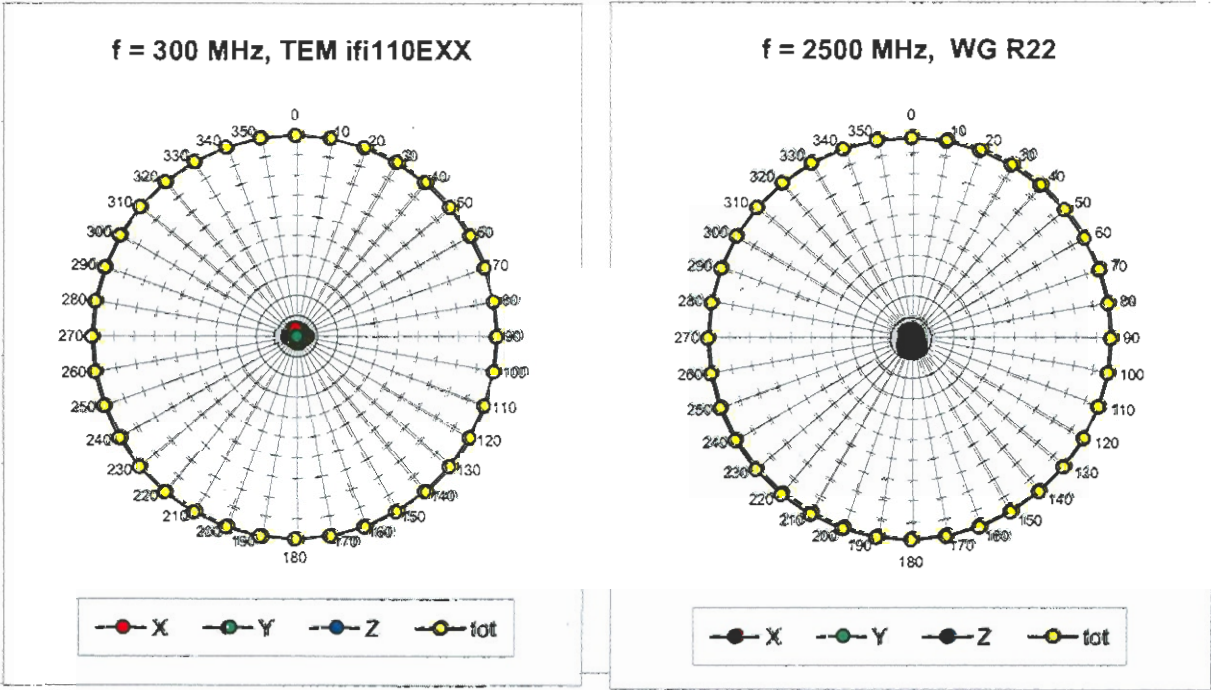


Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

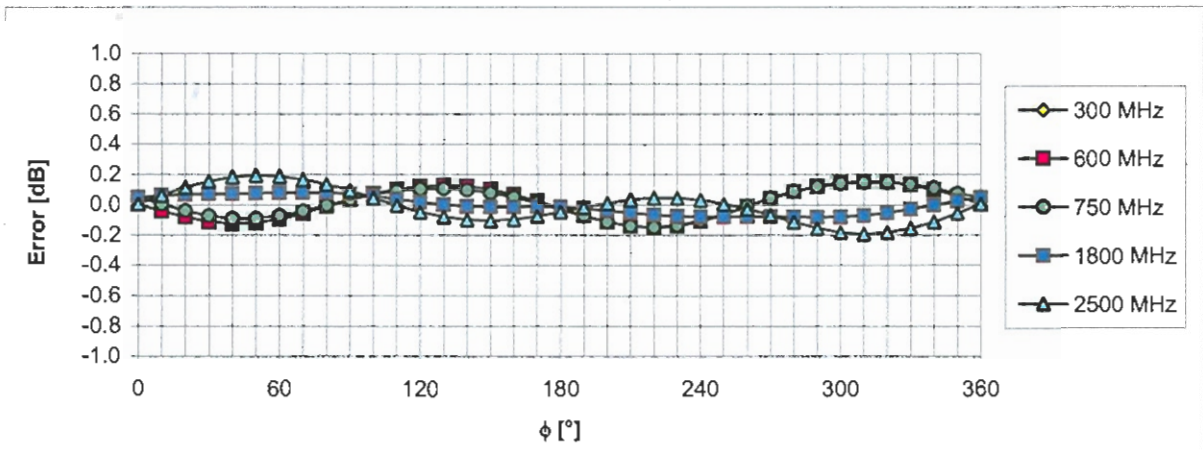
Receiving Pattern (ϕ), $\vartheta = 90^\circ$



Receiving Pattern (ϕ), $\vartheta = 0^\circ$

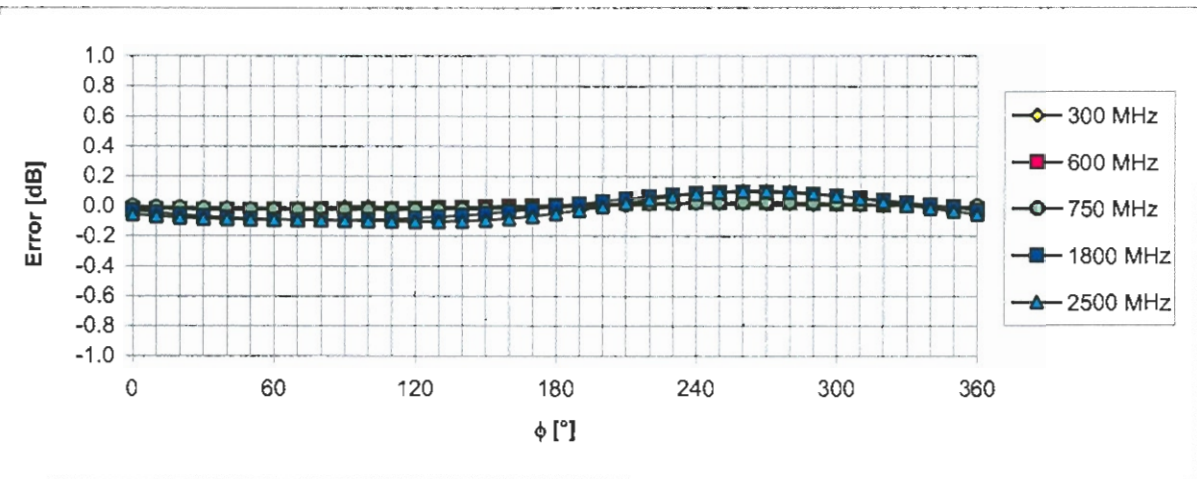


Receiving Pattern (ϕ), $\vartheta = 90^\circ$



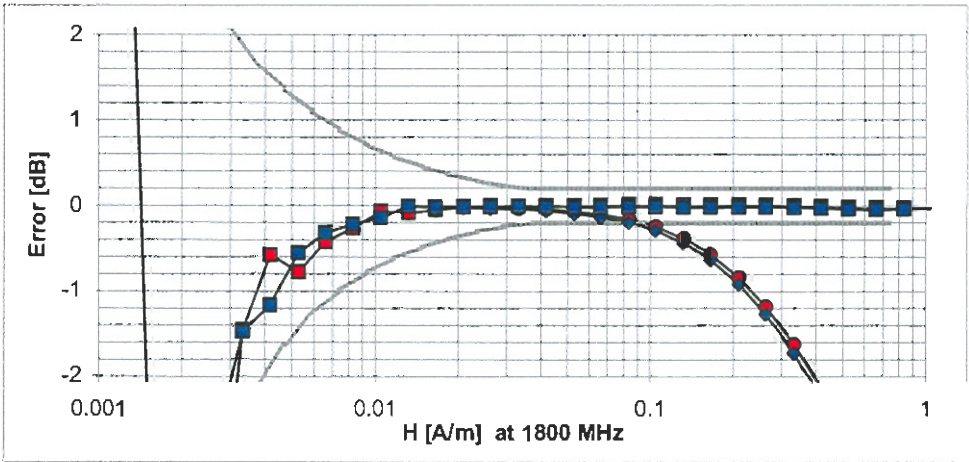
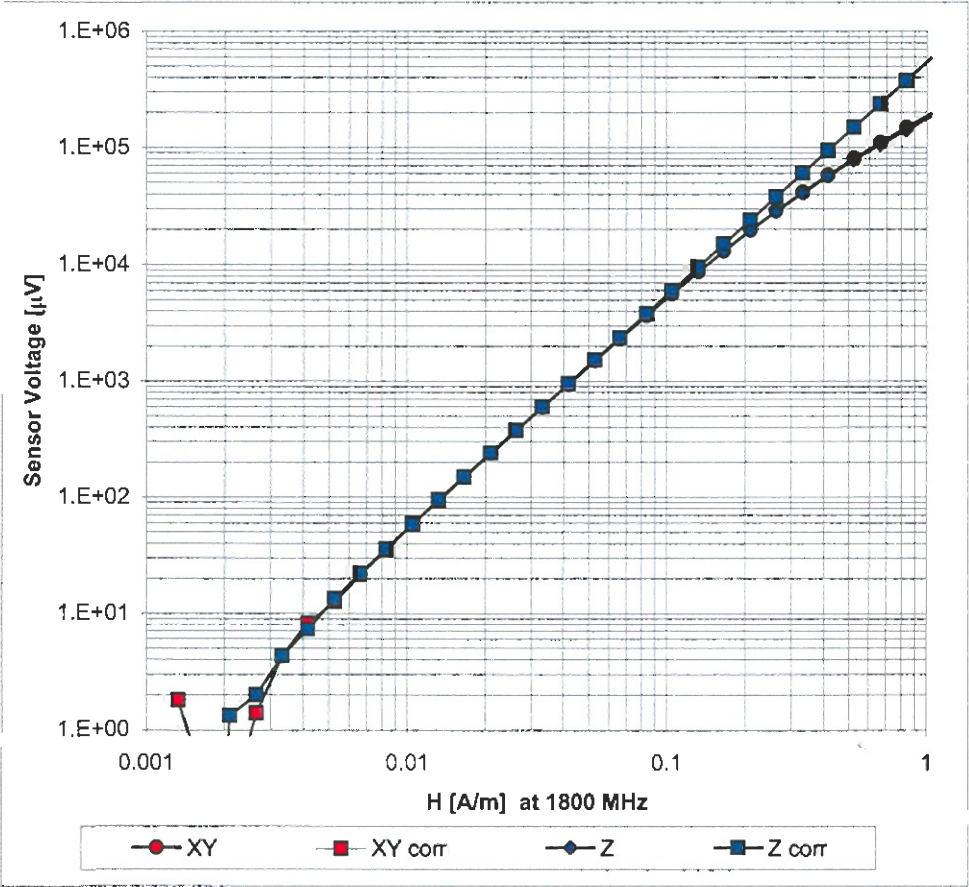
Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

Receiving Pattern (ϕ), $\vartheta = 0^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

Dynamic Range f(H-field)
(Waveguide R22, f = 1800 MHz)



Uncertainty of Linearity Assessment: $\pm 0.6\%$ (k=2)